



Analytics, Privacy and Security for IoT and Big Data

Guest Editors:

**Prof. Dr. Luis Javier Garcia
Villalba**

Prof. Dr. Tai-hoon Kim

**Dr. Robson de Oliveira
Albuquerque**

**Dr. Ana Lucila Sandoval
Orozco**

Deadline for manuscript
submissions:
closed (30 September 2022)

Message from the Guest Editors

The main objective of this Special Issue is to collect contributions by leading-edge researchers from academia and industry and show the latest research results in the rapidly developed field of analytics, privacy, and security for IoT and Big Data, therefore providing a valuable information venue to researchers as well as practitioners. Original and unpublished high-quality research results are solicited to explore various challenging topics which include but are not limited to:

Potential topics include but are not limited to:

- Authentication and access control for IOT;
- Big data analytics for threat and attack prediction;
- Biometric technologies and systems for IoT;
- Blockchain in the IoT;
- Data security and cryptosystems for IoT;
- Embedded security and privacy in IoT devices;
- Ethics and legal considerations in IoT;
- Privacy and anonymization techniques in IoT;
- Secure authentication of IoT devices;
- Secure wireless channel and traffic models;
- Security and privacy by design architectures for IoT;





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Editor-in-Chief

Prof. Dr. Giulio Nicola Cerullo
Dipartimento di Fisica,
Politecnico di Milano, Piazza L.
da Vinci 32, 20133 Milano, Italy

Message from the Editor-in-Chief

As the world of science becomes ever more specialized, researchers may lose themselves in the deep forest of the ever increasing number of subfields being created. This open access journal Applied Sciences has been started to link these subfields, so researchers can cut through the forest and see the surrounding, or quite distant fields and subfields to help develop his/her own research even further with the aid of this multi-dimensional network.

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Applied Sciences Editorial Office
MDPI, St. Alban-Anlage 66
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